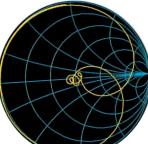


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## Agilent PNA Microwave Network Analyzers

**Please note:** This document does not contain Agilent's most up-to-date PNA Series network analyzer portfolio. This document is available for reference only for customers using Agilent's legacy network analyzers. To view the current Agilent PNA Microwave Network Analyzers brochure <u>click here</u>. PNA Network Analyzers: E8362/3/4B, E8361A 10 MHz to 20, 40, 50, 67, or 110 GHz

**PNA-L Network Analyzers: N5230A** 300 kHz to 6, 13.5, or 20 GHz 10 MHz to 20, 40, or 50 GHz

PNA-X Network Analyzers: N5242A 10 MHz to 26.5 GHz







**Agilent Technologies** 

## Welcome to the world of PNAs – The most popular microwave network analyzers

The PNA Series builds on Agilent's 40-year legacy of excellence to deliver new standards in speed, accuracy, and versatility for microwave network analysis. The PNA's architecture includes high quality, stable hardware and flexible software. The standard PNA is suitable for testing passive and active devices such as filters and amplifiers. Users can easily add options to test mixers, harmonics, intermodulation distortion (IMD), pulsed-RF, antennas and millimeter-wave (mmwave) components.

**PNA Models** 

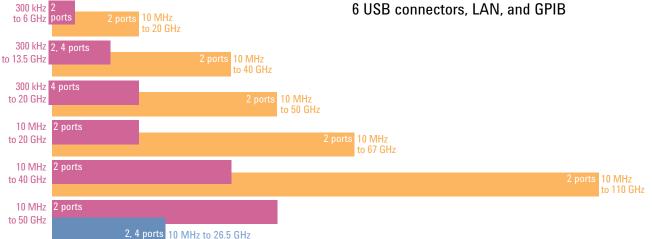
PNA-L

**PNA-X** 

PNA

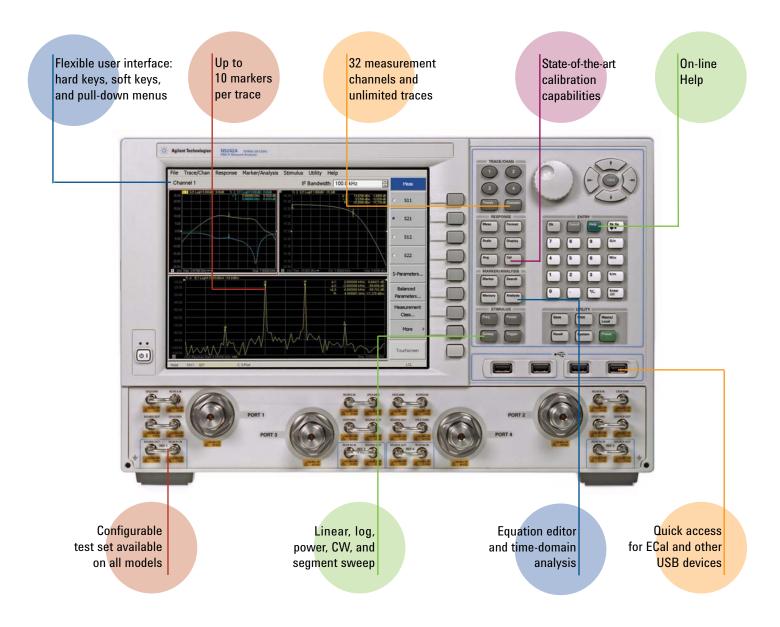
#### **Key features**

- Excellent performance
  - High dynamic range: 127 dB at 20 GHz at test port
  - Low trace noise: 0.002 dB rms at 1 kHz bandwidth
  - Fast measurement speed: 4.5 to 26 µsec/point
  - High stability: 0.05 dB/degrees Celsius
- State-of-the-art calibration capabilities and wide-range of ECal modules
- Advanced applications for mixer and pulse measurements
- Single-ended and balanced measurements
- 32 measurement channels, unlimited traces, and 16,001 points per channel
- Connectivity with Open Windows® XP, 6 USB connectors, LAN, and GPIB



Windows is a registered trademark of Microsoft Corporation.

### **Common features across the PNA Series**

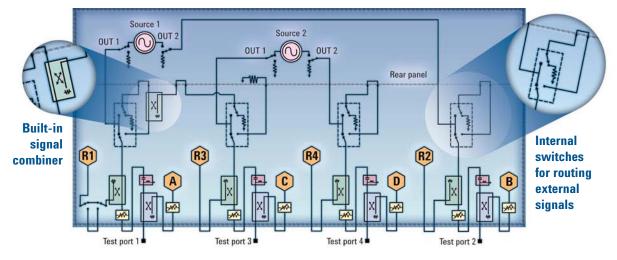




The PNA-X integrates a 10.4 inch high resolution display with a touch screen, which provides a crisp view and easy access to all data and traces. This enhanced user interface allows intuitive operation and helps you set up complex measurements quickly.

## **PNA-X** – The premier-performance microwave network analyzer

The industry-leading performance and highly integrated configurable nature of the PNA-X make it the ideal solution to address active device measurement challenges. The PNA-X enables engineers to stay on the leading edge of component testing.



PNA-X block diagram (shown with Options 400, 419, and 423).

#### **High quality synthesizers**

- 10 MHz to 26.5 GHz
- Internal 2nd source for IMD, hot-S<sub>22</sub>, and high speed swept-LO measurements
- High output power and wide power-sweep range for testing amplifiers
- Excellent harmonic performance for accurate harmonic and IMD measurements

#### **Sensitive and linear receivers**

- High compression point for improved dynamic accuracy
- More sensitivity for pulsed S-parameter measurements

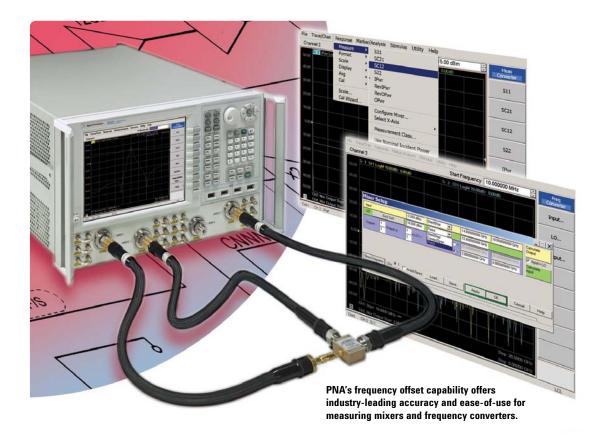
#### **Friendly user interface**

- Large 10.4 inch touch screen display
- Click-and-drag markers and zoom

#### **Exceptional flexibility**

- Built-in signal combiner for easy IMD and hot-S<sub>22</sub> measurements
- Easy pulsed measurements with internal pulse modulators and pulse generators
- Flexible signal routing via internal switches for adding external filters, pre-amplifiers, and additional test equipment
- Optional noise figure measurement capability extends the suite of measurements available with a single connection and offers the industry's highest accuracy
- Front-panel jumpers for direct access to test-port couplers and receivers
- Source and receiver attenuators with 5 dB increments for better measurement optimization
- Built-in bias-tees simplify amplifier evaluation
- Three sets of triggering lines for complex test systems

## **PNA-X** – Testing beyond the limits – *Mixers and Converters*

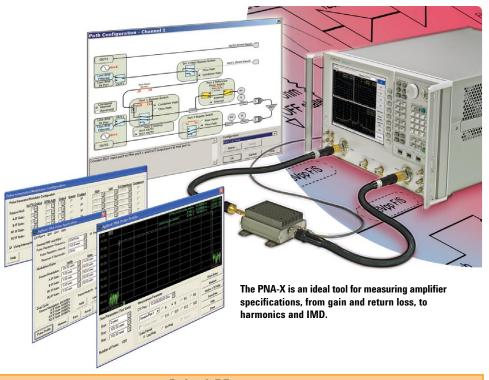


#### **Mixer measurements**

- Conversion loss/gain, magnitude and phase
- Input match, output match, and LO match
- Isolation and compression
- The two internal independent synthesizers with +13 dBm power and < 60 dBc harmonics eliminate the need for external synthesizers or components.
- Advanced error correction
  - Patented vector-mixer calibration for measurement of absolute group delay
  - Scalar-mixer calibration (SMC) for match-corrected amplitude measurements

- Significantly faster speed for fixed-IF (20 to 30 times faster than with an external source)
- Easy-to-configure multi-stage converter measurements
- LO source control and LO power calibration
- Mixer IMD
- The simple two-step SMC calibration provides match-corrected conversion loss, error-corrected input and output match
- Software tuning for embedded LO

## **PNA-X** – Ahead of the curve – Amplifiers, Pulsed-RF



#### **Amplifier measurements**

#### Checklist

- Gain, gain flatness, reverse isolation, and return loss
- Simple, fast, and accurate AM-AM and AM-PM compression measurements with the Gain Compression Application with 38 dB power sweep range at 20 GHz, +13 dBm output power
- Test harmonics accurately with < 60 dBc source harmonics. No need for external filters.</p>
- Accurate and simple IMD using the dual sources and internal combiner, located behind the couplers, providing highly accurate and stable measurements. No need for external combiners.
- Source corrected *noise figure measurements* with exceptional accuracy
- Integrated source attenuators and receiver attenuators for measurement optimization
- Perform all of the above measurements with one single connection using the PNA–X.

#### Pulsed-RF measurements

- Wideband and narrowband detection
- V Up to four internal pulse generators
- **V** Up to two **internal pulse modulators**
- Pulse widths as narrow as 33 ns
- V Pulse-to-pulse
- Point-in-pulse, average pulse, and pulse-profile capability
- No need for external components

# PNA-L – Advanced capability at an affordable price – *Passive and active devices, On-wafer test*



#### **Basic measurements**

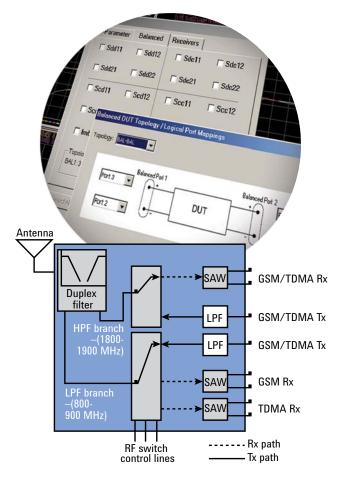
#### Checklist

- Insertion loss, gain, return loss, isolation, group delay, compression, both magnitude and phase
- Connectorized, in-fixture, or on-wafer
- Fast and accurate
- Reliable and repeatable
- V Affordable

#### **On-wafer measurements**

- Class of TRL calibrations for accurate measurements
- Differential measurement capabilities with integrated multiport network analyzers
- Accurate power control and de-embedding algorithm for device characterization
- Compatibility with on-wafer calibration software for a total solution

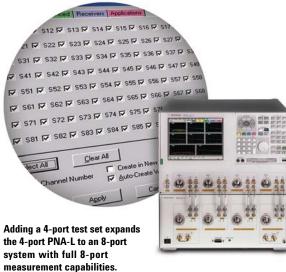
## **PNA-L – Speed and accuracy you can count on –** *Balanced/differential measurements and multiport test*



Tri-band antenna switch module with balanced and single-ended ports.

Easily measure single-ended, balanced, and mixed-mode S-parameters, in addition to ratioed and unratioed receiver measurements.

New multiport components require complicated test plans. Multiple port combinations must be tested over several frequency bands, resulting in lengthy tests. To reduce test time and lower costs, the PNA-L/PNA-X and test set combinations have been designed for high-speed measurements. To further simplify complex test requirements, up to 32 independent channels are available, eliminating the need for recalling instrument states.



#### **Differential measurements**

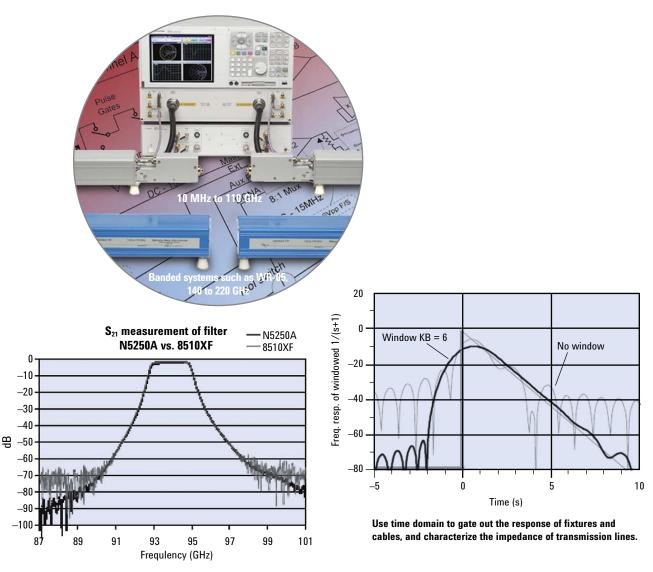
#### Checklist

- Single-ended, balanced, mixed-mode S-parameters
- Ratioed and unratioed measurements
- Mode-conversion analysis
- True-mode stimulus measurements

#### **Multiport measurements**

- Multiport configurations optimized for your device, including full cross-bar
- Quick-Short-Open-Load-Thru (QSOLT) for fast, multiport cal
- N-port calibration for accuracy and ease-of-measurements
- Test-set control part of PNA firmware
- 32 independent channels for fast measurement speed

### **PNA** – The solution for your mmwave needs



The N5250A PNA-based mmwave system has superb dynamic range. Shown here is the  $S_{21}$  of a filter at 94 GHz, compared to the 8510XF.

#### Millimeter-wave measurements

#### Checklist

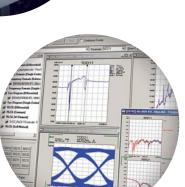
- PNA-based 10 MHz to 110 GHz bench-top system, extendable to 325 GHz
- Compact test-heads and two built-in synthesizers, for up to 110 GHz
- V Highly stable systems
- No external synthesizes to 325 GHz, when used with PNA-X
- Supported applications pulsed-RF, antenna, and on-wafer

#### **Time-domain analysis**

- Locate and resolve mismatches in the fixture, cable, or transmission lines
- Use gating to remove unwanted responses
- Fault-location

## PNA Series simplifies measurements – When the requirements are difficult *Modeling, PLTS, Antenna, Materials test*





#### High-frequency design and modeling

#### Checklist

- PNA drivers included in Connection Manager for easy connectivity
- Simple downloading of S-parameters into ADS for simulation
- Save ".s2p, .s4p, snp" files and import into ADS
- Modeling of devices using IC-CAP and PNA network analyzers

#### **Physical Layer Test Systems (PLTS)**

#### Checklist

- **V** RLCG model extraction and eye-diagrams
- High-speed differential interconnect design
- Multiple aggressor differential crosstalk

#### Antenna measurements

#### Checklist

- ✓ 20,001 points per channel
- Fast measurement speed, 4.5 µs/pt
- Forward and reverse sweeps for near-field scans
- V High-sensitivity

#### Materials measurements

#### Checklist

- Measurement of dielectric and magnetic properties
- Viewing of data in real, imaginary, loss tangent, and Cole-Cole formats
- Availability of a variety of techniques to meet your materials needs





### www.agilent.com/find/pna

## PNA-L/PNA/PNA-X comparison table

Device type	Required measurements	PNA-L	PNA	PNA-X
Mixers				
	Frequency-offset mode	•	•	•
	Conversion loss, isolation, and return loss	•	•	•
	Control of external source for mixer measurements	•	•	•
	Second internal source, used as LO on 2-port analyzer			•
	Second internal source, used as LO on 4-port analyzer	•		•
	Scalar calibrated converter measurements (SMC)	•	•	•
	Vector calibrated converter measurements (VMC)		•	•
	Software tuning for embedded LO		•	•
	+13 dBm output power on 2-ports (for LO)			•
	Compression, AM-PM conversion	•	•	•
Amplifiers				
	Gain, return loss, and reverse isolation	•	•	•
	Power sweep, compression, and AM-PM conversion	•	•	•
	Gain Compression Application			•
	Maximum output power level	Good	Good	Superb
	Power-sweep range for compression test	Good	Good	Superb
	Receiver compression point	Good	Good	Superb
	Internal bias-tees	0004	•	•
	Source attenuators	• 1	•	•
	Receiver attenuators		•	•
	Connection loop before reference path <sup>2</sup>			•
	Connection loops for attenuators, etc.	•	•	•
	Harmonics measurements	•	•	•
	Analyzer source harmonics	Good	Good	Superb
	Intermodulation distortion	•	•	•
	Second internal source for IMD on 2-port analyzer			•
	Second internal source for IMD on 2-port analyzer	•		•
	Internal combiner for IMD testing			•
	Hot-S <sub>22</sub>	Good		Superb
	Noise figure	0000		•
Pulsed-RF				
	Built-in pulse generator and modulators			•
	Wideband detection	Good	•	Superb
	Narrowband detection	0000	Good	Superb
	Pulse-profile	•	•	•
	Point-in-pulse	•	•	•
	Average pulse	•	•	•
	Pulse-to-pulse	•	•	-
	r uise-io-huise	lonard	•	-
		Legend •	Solution available	
		Blank	Solution not available	le

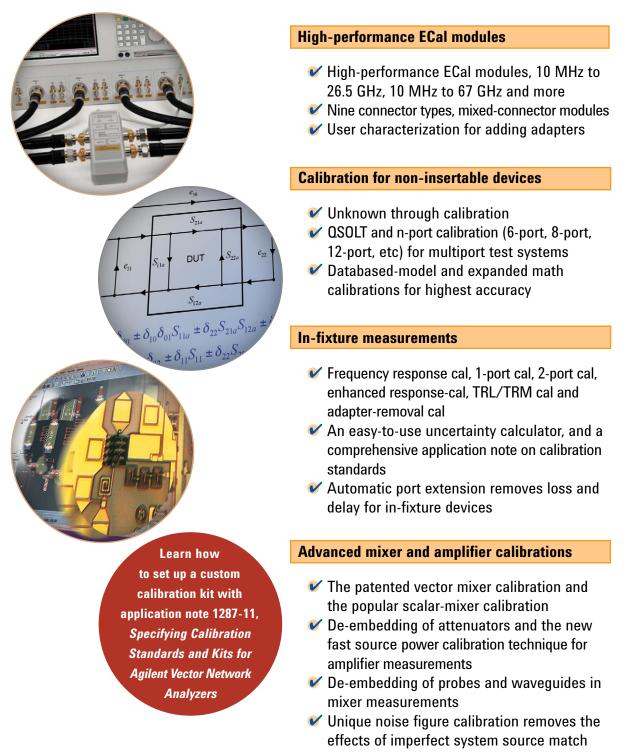
**Good and superb** Solution available, quality of solution qualified. For example, with maximum output power levels, all PNAs have output power, but the PNA-X has the highest output power.

1. 4-port PNA-L has one source attenuator. 4-port PNA-X has 4 source attenuators.

<sup>2.</sup> Applicable to high-power amplifier testing or integration of the external test equipment.

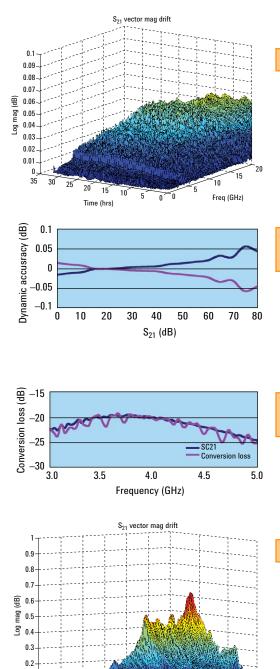
## **PNA – State-of-the-art calibration capabilities**

Calibrating network analyzers is critical for high accuracy measurements and can be particularly challenging in non-coaxial environments such as fixtures, wafers, or waveguides. Additionally, 3- and 4-port devices are more prevalent than ever and require more sophisticated calibration procedures. The need has never been greater for calibration tools that are more accurate and easier to use. The PNA's state-of-the-art calibration techniques help solve these challenges, enhance ease-of-use, and improve accuracy.



### **PNA - The standard for accuracy**

All the network analyzers in the PNA family are known for their high-levels of stability, contributing to accurate calibrations and measurements. With the PNA-X, users can benefit from exceptional levels of dynamic accuracy. For users in non-linear environments, the PNA's Scalar Mixer Calibration provides a higher level of measurement accuracy.



0.1-0-

20

Time (hrs)

10

#### Stability of a 20 GHz PNA over a 30-hour period<sup>1</sup>

It is clear that the more stable the hardware, the better the calibration, since it can correct the errors better. The calibration will remain stable as a function of time and temperature, and calibrations will not need to be updated as often.

## Typical dynamic accuracy of a PNA-X, with –20 dBm power

If you are measuring a device with 20 dB insertion loss, the contribution of the dynamic accuracy error (receiver linearity) is **less than 0.01 dB**.

## Scalar-mixer calibration versus a simple power meter/receiver calibration

Note the effects of mismatch that are corrected for by SMC.

#### 110 GHz PNA drift over a 24-hour period<sup>1</sup>

As you can see on the graph, the 110 GHz PNA drifts less than **0.7 dB, after 24 hours, at 110 GHz.** Agilent's 110 GHz PNA system is the most stable mmwave system in the industry.

1. Measurements made at  $25 \pm 1$  degree Celcuis.

120

80 100

60

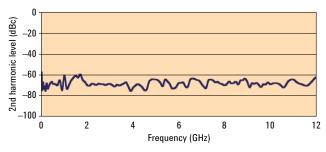
Freq (GHz)

20 40

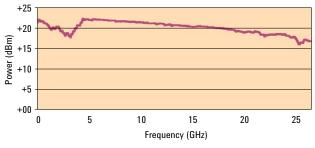
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## **Outstanding performance**

Parameter	20 GHz 2-port PNA E8362B	20 GHz 2-port PNA-L N5230A Opt 220	20 GHz 4-port PNA-L N5230A Opt 240	26.5 GHz 2-port PNA-X N5242A Opt 200	26.5 GHz 4-port PNA-X N5242A Opt 400
Frequency range	10 MHz to 20 GHz	10 MHz to 20 GHz	300 kHz to 20 GHz	10 MHz to 26.5 GHz	10 MHz to 26.5 GHz
# of Ports	2	2	4	2	4
Dynamic range <sup>1</sup>	123 dB	108 dB	103 dB	127 dB	127 dB
Noise floor	–120 dBm	–105 dBm	–106 dBm	–114 dBm	–114 dBm
Max output power	+3 dBm	+3 dBm	–3 dBm	+13 dBm	+13 dBm
0.1 dB compression	–5 dBm input	+6 dBm input	+9 dBm input	+12 dBm input	+12 dBm input
Trace noise	0.006 dB rms	0.006 dB rms	0.010 dB rms	0.005 dB rms	0.005 dB rms
	1 kHz IFBW	1 kHz IFBW	100 kHz IFBW	100 kHz IFBW	100 kHz IFBW
	0 dBm	–5 dBm	–5 dBm	–5 dBm	–5 dBm
ALC range	27 dB	23 dB	22 dB	38 dB	38 dB
Max IFBW	40 kHz	250 kHz	600 kHz	5 MHz	5 MHz
Speed	26 µs/pt	9 µs∕pt	4.5 µs∕pt	4.5 µs∕pt	4.5 µs∕pt
Display size, LCD	21.3 cm	21.3 cm	21.3 cm	26.4 cm	26.4 cm
Touch screen	No	No	No	Yes	Yes







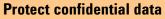
Typical PNA-X output power

Parameter	40 GHz PNA-L N5230A Option 420	40 GHz PNA E8363B
Frequency range	10 MHz to 40 GHz	10 MHz to 40 GHz
Dynamic range	90 dB	110 dB
Noise floor	–95 dBm	–114 dBm
Max output power	–5 dBm	–4 dBm
0.1 dB compression	–8.5 dBm	–12.5 dBm
Trace noise (1 kHz)	0.020 dB rms	0.006 dB rms
ALC range	20 dB	20 dB
Max IFBW	250 kHz	40 kHz
Speed	9 µs∕pt	26 µs/pt

1. 20 GHz, test port, 10 Hz IFBW.

## **Completing the solution**





The best method for maintaining security is to remove the hard disk drive. The PNA provides the removable hard disk drive as a standard feature, enabling you to easily remove the drive and keep it safe in a secure area.

#### Protect your software investment

Agilent protects your 8753, 8720 and 8510 software investment by providing migration tools to reduce your code conversion effort. www.agilent.com/find/nadisco

#### Network analyzer forum

Visit the online network analyzer discussion forum where you can learn how your peers are solving some of their most challenging measurement problems. www.agilent.com/find/agilent naforum

## Free CD - Network analyzer application notes and video demos

Application topics include amplifiers, mixers/ converters, pulsed-RF, millimeter/sub millimeterwave, and materials measurements. www.agilent.com/find/nacd







### Web resources

Visit our Web sites for additional product information and literature.

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Shuttle photo on the cover courtesy of NASA.

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